

CE EMC Test Report

Report No.: CE190401D10A

Test Model: EMBC-2000

- Series Model: EMBC-2XXXX-XXXX series ("X" can be 0-9, A-Z or blank for marketing purpose)
- Received Date: Apr. 1, 2019

Test Date: Apr. 10 to 26, 2019

Issued Date: May 28, 2019

Applicant: Vecow Co., Ltd.

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Issue No.	Description	Date Issued
CE190401D10A	Original release.	May 28, 2019



1 **Certificate of Conformity**

Product:	Motherboard
Brand:	Vecow
Test Model:	EMBC-2000
Series Model:	EMBC-2XXXX-XXXX series ("X" can be 0-9, A-Z or blank for marketing purpose)
Sample Status:	Engineering sample
Applicant:	Vecow Co., Ltd.
Test Date:	Apr. 10 to 26, 2019
Standards:	EN 55032:2015 +AC:2016, Class A
	EN 61000-3-2:2014
	EN 61000-3-3:2013
	EN 55024:2010 / EN 55024:2010 +A1:2015
	EN 61000-4-2:2009 / IEC 61000-4-2:2008 ED. 2.0
	EN 61000-4-3:2006 +A1:2008 +A2:2010 / IEC 61000-4-3:2010 ED. 3.2
	EN 61000-4-4:2012 / IEC 61000-4-4:2012 ED. 3.0
	EN 61000-4-5:2014 +A1:2017 / IEC 61000-4-5:2014 +A1:2017 ED. 3.0
	EN 61000-4-6:2014 +AC:2015 / IEC 61000-4-6:2013 ED. 4.0
	EN 61000-4-8:2010 / IEC 61000-4-8:2009 ED. 2.0
	EN 61000-4-11:2004 +A1:2017 / IEC 61000-4-11:2004 +A1:2017 ED. 2.0

The above equipment has been tested by Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch, and found compliance with the requirement of the above standards. The test record, data evaluation & Equipment Under Test (EUT) configurations represented herein are true and accurate accounts of the measurements of the sample's EMC characteristics under the conditions specified in this report.

Prepared by :

pee Um

May 28, 2019 Date:

Albee Chu / Specialist

Date: May 28, 2019

Approved by :

Jim Hsiang / Associate Technical Manager



2 Summary of Test Results

Emission			
Standard	Test Item	Result/Remarks	Verdict
	Conducted emission from the AC mains power port	Minimum passing Class A margin is -21.99 dB at 0.66813 MHz	Pass
EN 55032:2015 +AC:2016	Asymmetric mode conducted emission at telecommunication ports	Minimum passing Class A margin is -19.04 dB at 0.49408 MHz	Pass
	Radiated emission 30-1000 MHz	Minimum passing Class A margin is -2.04 dB at 226.29 MHz	Pass
	Radiated emission above 1GHz	Minimum passing Class A margin is -12.42 dB at 1186.79 MHz	Pass
EN 61000-3-2:2014 Harmonic current emissions		The power consumption of EUT is less than 75W and no limits apply.	Pass
EN 61000-3-3:2013	Voltage fluctuations and flicker	$\begin{array}{ll} P_{st} \leqq 1.0 & d_{max} \leqq 4\% \\ P_{lt} \leqq 0.65 & d_{c} \leqq 3.3\% \\ T_{max} \leqq 500 ms \end{array}$	Pass

Immunity				
EN 55024 Clause	Basic standard	Test Item	Result/Remarks	Verdict
4.2.1	EN 61000-4-2:2009 / IEC 61000-4-2:2008 ED. 2.0	Electrostatic discharges (ESD)	Performance Criterion B	Pass
4.2.3.2	EN 61000-4-3:2006 +A1:2008 +A2:2010 / IEC 61000-4-3:2010 ED. 3.2 ED. 3.2 ED. 3.2 ED. 3.2 ED. 3.2 ED. 3.2 ED. 3.2		Pass	
4.2.2	EN 61000-4-4:2012 / IEC 61000-4-4:2012 ED. 3.0	Electrical fast transients (EFT)	Performance Criterion A	Pass
4.2.5	EN 61000-4-5:2014 +A1:2017 / IEC 61000-4-5:2014 +A1:2017 ED. 3.0	Surges	Performance Criterion B	Pass
4.2.3.3	EN 61000-4-6:2014 +AC:2015 / IEC 61000-4-6:2013 ED. 4.0	Continuous conducted disturbances (CS)	Performance Criterion A	Pass
4.2.4	EN 61000-4-8:2010 / IEC 61000-4-8:2009 ED. 2.0	Power-frequency magnetic fields (PFMF)	Performance Criterion A	Pass
4.2.6	EN 61000-4-11:2004 +A1:2017 / IEC 61000-4-11:2004 +A1:2017 ED. 2.0	Voltage dips and interruptions	Voltage Dips: >95% reduction – 0.5 period, Performance Criterion A 30% reduction – 25 periods, Performance Criterion A Voltage Interruptions: >95% reduction – 250 periods, Performance Criterion C	Pass

Note:

1. There is no deviation to the applied test methods and requirements covered by the scope of this report.

2. The above EN/IEC basic standards are applied with latest version if customer has no special requirement.

3. Determining compliance based on the results of the compliance measurement, not taking into account measurement instrumentation uncertainty.



2.1 Measurement Uncertainty

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2:

Measurement	Expended Uncertainty (k=2) (±)	Maximum allowable uncertainty (±)
Conducted emission from AC mains power port using AMN, 150kHz ~ 30MHz	2.79 dB	3.4 dB (U _{cispr})
Asymmetric mode conducted emission using AAN, 150kHz ~ 30MHz	3.94 dB	5.0 dB (<i>U</i> _{cispr})
Radiated emission, 30MHz ~ 1GHz	3.91 dB	6.3 dB (<i>U</i> _{cispr})
Radiated emission, 1GHz ~ 6GHz	5.12 dB	5.2 dB (<i>U</i> _{cispr})

2.2 Modification Record

There were no modifications required for compliance.



3 General Information

3.1 Description of EUT

Product	Motherboard
Brand	Vecow
Test Model	EMBC-2000
Series Model	EMBC-2XXXX-XXXX series ("X" can be 0-9, A-Z or blank for marketing purpose)
Model Difference	Marketing Differentiation
Sample Status	Engineering sample
Operating Software	N/A
Power Supply Rating	DC from host equipment
Accessory Device	N/A
Data Cable Supplied	N/A

Note:

1. The EUT is a Motherboard with resolution up to 3480 x 2160 @ 30Hz (HDMI) and 1920 x 1440 @ 60Hz (VGA).

2. The EUT was installed into a PC (Brand: Vecow, Model: SPC-4020A), which was was configured with the following key components

Processor	Intel Atom [®] x7-E3950 Processor (Apollo Lake-I)
BIOS	AMI
SIO	IT8786E
Memory	1 DDR3L 1866MHz SO-DIMM, up to 8GB
OS	Windows 10, Linux

3. ThePC uses following adapter and it was provided for test by client:

Brand	MW
Model	GST280A12
Input Power	100-240Vac, 50/60Hz, 4.5A
Output Power	12V, 21A, 252W
Power Line	Non-shielded DC (1.0m) with two ferrite cores

3.2 Features of EUT

The tests reported herein were performed according to the method specified by Vecow Co., Ltd., for detailed feature description, please refer to the manufacturer's specifications or user's manual.



3.3 Operating Modes of EUT and Determination of Worst Case Operating Mode

- 1. The EUT was pre-tested under operating and standby condition and the worst emission level was found under **operating condition**.
- 2. The EUT consumes power from PC, which designed with AC power supply of rating 100-240Vac, 50/60Hz.

For radiated emission evaluation, 230Vac/50Hz & 110Vac/60Hz (EN 55032), 120Vac/60Hz (for FCC Part 15) had been covered during the pre-test. The worst data was found at **110Vac/60Hz** and recorded in the applied test report.

3. Test modes are presented in the report as below.

Mode	Input Power								
Mode	Test Condition	(System)							
	Conducted emission test								
4		230Vac/ 50Hz &							
	Full system, HDMI (3480 x 2160 @ 30Hz)+ VGA* (1920x 1200 @ 60Hz)	110Vac/ 60Hz							
	Asymmetric mode conducted emission at telecommunication ports								
	Full system, HDMI (3480 x 2160 @ 30Hz)+ VGA* (1920x 1200 @ 60Hz),								
4	LAN port 1, 1Gbps	000) (/ 501 -							
I	Full system, HDMI (3480 x 2160 @ 30Hz)+ VGA* (1920x 1200 @ 60Hz),	230Vac/ 50Hz							
	LAN port 2, 1Gbps								
The idle mo	ode of conducted emission test at telecom port was pre-tested based on the wors	st case of link							
mode. Due	to emissions of idle mode being very low compared to link mode, only the link m	ode data were							
presented i	n the test report.								
	Radiated emission test								
1	Full system, HDMI (3480 x 2160 @ 30Hz)+ VGA* (1920x 1200 @ 60Hz)	110Vac/ 60Hz							
	Harmonics, Flicker, Immunity tests								
1	Full system, HDMI (3480 x 2160 @ 30Hz)+ VGA* (1920x 1200 @ 60Hz)	230Vac/ 50Hz							
Note: *The	maximum resolution of the external display monitor is 1920x 1200 @ 60Hz								

3.4 Test Program Used and Operation Descriptions

Emission tests (Harmonics & Flicker excluded):

- a. Installed the EUT into PC.
- b. Turned on the power of all equipment.
- c. PC ran a test program to enable all functions.
- d. PC read and wrote messages from/to SSD and ext. HDD.
- e. PC sent and received messages to/from Notebook PCs (kept in a remote area) via two LAN cables.
- f. PC sent "color bars with moving element" messages to ext. LCD Monitors. Then they displayed "color bars with moving element" messages on their screens simultaneously.
- g. PC sent 1kHz audio signal to earphone.
- h. PC sent messages to modem.
- i. PC sent messages to printer and printer printed them out.
- j. Steps d-i were repeated.

Harmonics, Flicker, Immunity tests:

- a. Installed the EUT into PC.
- b. Turned on the power of all equipment.
- c. PC ran a test program to enable all functions.
- d. PC read and wrote messages from/to SSD and ext. USB flashs.
- e. PC sent and received messages to/from Notebook PCs (kept in a remote area) via two UTP LAN cables.
- f. PC sent "H" messages to ext. LCD Monitors. Then they displayed "H" patterns on their screens simultaneously.
- g. PC sent audio signal to speaker.
- h. PC sent messages to modem.
- i. Steps d-h were repeated.

3.5 Primary Clock Frequencies of Internal Source

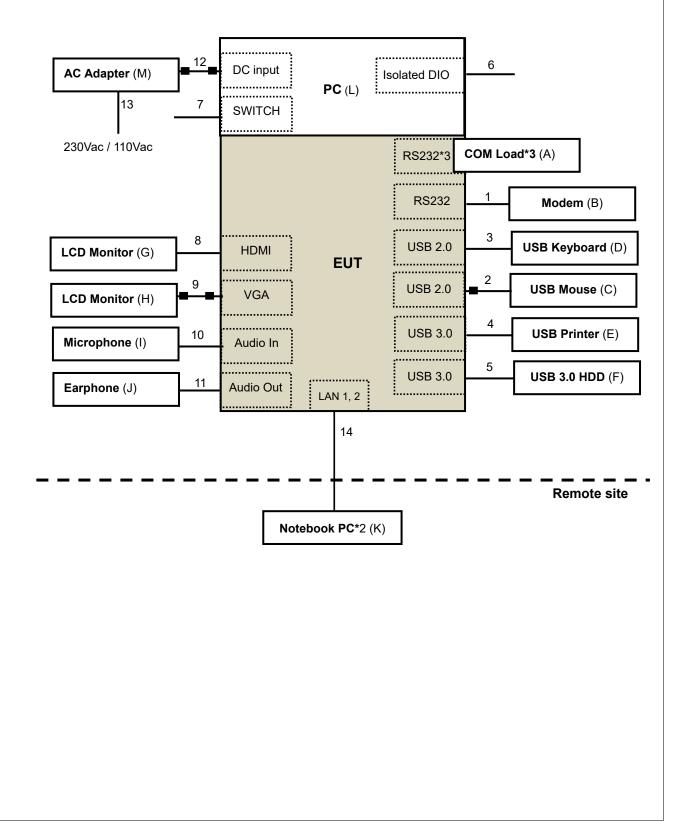
The highest frequency generated or used within the EUT or on which the EUT operates or tunes is 1600 MHz, provided by Vecow Co., Ltd., for detailed internal source, please refer to the manufacturer's specifications.

4 Configuration and Connections with EUT

4.1 Connection Diagram of EUT and Peripheral Devices

Emission tests (Harmonics & Flicker excluded):







Harmonics, Flicker, Immunity tests: **TEST CONFIGURATION** 6 5 DC input AC Adapter (L) Isolated DIO **PC** (K) 12 7 SWITCH ŝ 230Vac COM Load*3 (A) RS232*3 8 LCD Monitor (G) HDMI 1 **RS232** Modem (B) İ..... 9 VGA 3 LCD Monitor (H) EUT USB Keyboard (D) **USB 2.0** 10 2 Microphone (I) Audio In USB Mouse (C) USB 2.0 :..... 11 Audio Out USB Disk (E) Speaker (J) USB 3.0 :..... USB 3.0 USB Disk (E) i..... LAN 1, 2 4 Notebook PC*2 (F)

Remote site



4.2 Configuration of Peripheral Devices and Cable Connections

ID	Product	Brand	Model No.	Serial No.	FCC ID	Remarks				
Α.	COM Load*3	N/A	N/A	N/A	N/A	Provided by Lab				
В.	MODEM	ACEEX	1414	980020531	IFAXDM1414	Provided by Lab				
C.	USB Mouse	Microsoft	1113	9170515772204	FCC DoC Approved	Provided by Lab				
D.	USB KEYBOARD	Dell	KB216t	CN-0W33XP-LO300- 7CL-1907	FCC DoC Approved	Provided by Lab				
E.	Printer	HP	Officejet pro 251dw	N/A	B94SDGOB1191	Provided by Lab				
F.	USB 3.0 Hard Disk	WD	WDBUZG0010BBK- PESN	WXF1E84H2ASN	FCC DoC Approved	Provided by Lab				
G.	LCD Monitor	ASUS	MG28UQ	H8LMTF147971	FCC DoC Approved	Provided by Lab				
Н.	LCD Monitor	DELL	U2410	CN082WXD728720 CC10NL	FCC DoC Approved	Provided by Lab				
Ι.	MICROPHONE	Labtec	mic-333	N/A	N/A	Provided by Lab				
J.	EARPHONE	PHILIPS	SBC HL145	N/A	N/A	Provided by Lab				
	Notebook PC	DELL	P41G	FT4W952	FCC DoC Approved	Provided by Lab				
Κ.	Notebook PC	ASUS	PU401L	ECNXBC012528528	FCC DoC Approved	Provided by Lab				
L.	PC	Vecow	SPC-4020A	N/A	N/A	Supplied by client				
М.	AC Adapter	MW	GST280A12	N/A	N/A	Supplied by client				
NI . 4 .										

Emission tests (Harmonics & Flicker excluded):

Note:

1. All power cords of the above support units are non-shielded (1.8m).

2. Item K acted as communication partners to transfer data.

ID	Descriptions	Qty.	Length (m)	Shielding (Yes/No)	Cores (Qty.)	Remarks
1.	RS232 cable	1	1.2	Y	0	Provided by Lab
2.	USB cable	1	1.8	Y	1	Provided by Lab
3.	USB cable	1	1.8	Y	0	Provided by Lab
4.	USB cable	1	1.8	Y	0	Provided by Lab
5.	USB cable	1	0.5	Y	0	Provided by Lab
6.	Signal cable	1	0.3	N	0	Supplied by client
7.	Signal cable	1	0.7	N	0	Supplied by client
8.	HDMI cable	1	2.0	Y	0	Provided by Lab
9.	D-Sub cable	1	1.8	Y	2	Provided by Lab
10.	Audio cable	1	1.2	N	0	Provided by Lab
11.	Audio cable	1	2.2	N	0	Provided by Lab
12.	DC power	1	1.0	N	2	Supplied by client
13.	AC power cord	1	1.8	N	0	Provided by Lab
14.	LAN cable (Cat.5e)	2	10	N	0	Provided by Lab

Note: The core(s) is(are) originally attached to the cable(s).



	, ,					
ID	Product	Brand	Model No.	Serial No.	FCC ID	Remarks
Α.	COM Load*3	N/A	N/A	N/A	N/A	Provided by Lab
В.	MODEM	ACEEX	1414	0206026741	IFAXDM1414	Provided by Lab
C.	USB Mouse	HP	N910U	N/A	FCC DoC Approved	Provided by Lab
D.	USB KEYBOARD	HP	KU-1060	N/A	FCC DoC Approved	Provided by Lab
_	USB Hard Disk	SP	N/A	N/A	N/A	Provided by Lab
E.	USB Hard Disk	SP	N/A	N/A	N/A	Provided by Lab
L	Notebook PC	LENOVO	TP00057A	R9-0JMLFS16/01	FCC DoC Approved	Provided by Lab
F.	Notebook PC	LENOVO	T470	PF-0QW0NQ	FCC DoC Approved	Provided by Lab
G.	LCD Monitor	DELL	UP2516DT	CN-03JV40-74445-6 6U-197L	FCC DoC Approved	Provided by Lab
H.	LCD Monitor	DELL	U2412M	CN-07N2FG-TV100- 7BG-039L	FCC DoC Approved	Provided by Lab
Ι.	MICROPHONE	N/A	N/A	N/A	N/A	Provided by Lab
J.	Speaker	N/A	N/A	N/A	N/A	Provided by Lab
Κ.	PC	Vecow	SPC-4020A	N/A	N/A	Supplied by client
L.	AC Adapter	MW	GST280A12	N/A	N/A	Supplied by client

Harmonics, Flicker, Immunity tests:

Note:

1. All power cords of the above support units are non-shielded (1.8m).

2. Item ${\sf F}$ acted as communication partners to transfer data.

ID	Descriptions	Qty.	Length (m)	Shielding (Yes/No)	Cores (Qty.)	Remarks
1.	RS232 cable	1	1.2	Y	0	Provided by Lab
2.	USB cable	1	1.8	Y	0	Provided by Lab
3.	USB cable	1	1.8	Y	0	Provided by Lab
4.	LAN cable (Cat.5e)	2	10	Ν	0	Provided by Lab
5.	DC power	1	1.0	Ν	2	Supplied by client
6.	Signal cable	1	0.3	Ν	0	Supplied by client
7.	Signal cable	1	0.7	Ν	0	Supplied by client
8.	HDMI cable	1	1.8	Y	0	Provided by Lab
9.	D-Sub cable	1	1.8	Y	2	Provided by Lab
10.	Audio cable	1	1.2	Ν	0	Provided by Lab
11.	Audio cable	1	1.2	N	0	Provided by Lab
12.	AC power cord	1	1.8	N	0	Provided by Lab

Note: The core(s) is(are) originally attached to the cable(s).



5 Conducted Emission from the AC Mains Power Port

5.1 Limits

quency range (MHz) Coupling device [Class A limits (dBuV)
	Quasi posk / 0kHz	79
ΔΝΛΝΙ		73
Aivin	Average / OkHz	66
	Average / 9KHZ	60
	Coupling device	Quasi-peak / 9kHz

Frequency range (MHz)	requency range (MHz) Coupling device		Class B limits (dBuV)
0.15 - 0.5			66 - 56
0.5 - 5		Quasi-peak / 9kHz	56
5 - 30.0	AMN		60
0.15 - 0.5	Aivin		56 - 46
0.5 - 5		Average / 9kHz	46
5 - 30.0			50

5.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
ROHDE & SCHWARZ TEST RECEIVER	ESR3	102414	Jan. 17, 2019	Jan. 16, 2020
ROHDE & SCHWARZ Artificial Mains Network (for EUT)	ENV216	101197	May 23, 2018	May 22, 2019
LISN With Adapter (for EUT)	AD10	C10Ada-002	May 23, 2018	May 22, 2019
ROHDE & SCHWARZ Artificial Mains Network (for peripherals)	ESH3-Z5	100218	Nov. 30, 2018	Nov. 29, 2019
SCHWARZBECK Artificial Mains Network (For EUT)	NNLK8129	8129229	May 3, 2018	May 2, 2019
SCHWARZBECK Artificial Mains Network (For EUT)	NNLK 8121	8121-808	Mar. 15, 2019	Mar. 14, 2020
Software	Cond_V7.3.7.4	NA	NA	NA
RF cable (JYEBAO) With 10dB PAD	5D-FB	Cable-C10.01	Feb. 13, 2019	Feb. 12, 2020
SUHNER Terminator (For ROHDE & SCHWARZ LISN)	65BNC-5001	E1-011484	May 8, 2018	May 7, 2019
ROHDE & SCHWARZ Artificial Mains Network (For TV EUT)	ESH3-Z5	100220	Nov. 21, 2018	Nov. 20, 2019
LISN With Adapter (for TV EUT)	100220	NA	Nov. 21, 2018	Nov. 20, 2019

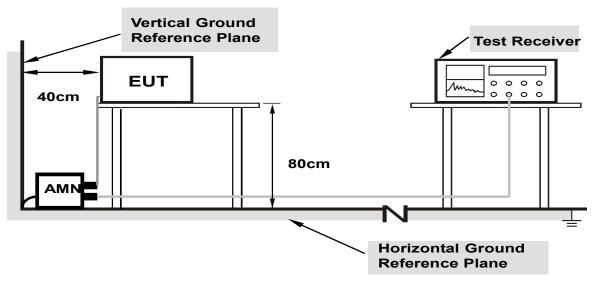
Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

- 2. The test was performed in Shielded Room No. 10.
- 3. The VCCI Site Registration No. C-11852.
- 4. Tested Date: Apr. 11, 2019



5.3 Test Arrangement

- a. The EUT was placed 0.4 meters from the conducting wall of the shielded room with EUT being connected to the power mains through an Artificial Mains Network (AMN). Other support units were connected to the power mains through another AMN. The two AMNs provide 50 Ohm/ 50uH of coupling impedance for the measuring instrument.
- b. Both lines of the power mains connected to the EUT were checked for maximum conducted interference.
- c. The test results of conducted emissions at mains ports are recorded of six worst margins for quasi-peak (mandatory) [and average (if necessary)] values against the limits at frequencies of interest unless the margin is 20 dB or greater.
- Note: The resolution bandwidth and video bandwidth of test receiver is 9kHz for quasi-peak detection (QP) and average detection (AV) at frequency 0.15MHz-30MHz.



Note: 1. Support units were connected to second AMN.

2. The distance specified between EUT/AE and other metallic objects is ≥ 0.8 m in the measurement arrangement for table-top EUT.

3. Cable on the RGP must to be insulated.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

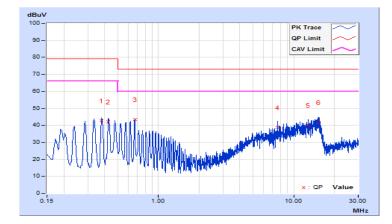


5.4 Test Results

Frequency Range	150kHz ~ 30MHz	Detector Function & Bandwidth	Quasi-Peak (QP) / Average (AV), 9kHz
Input Power (System)	110Vac 60Hz	Environmental Conditions	25℃, 69%RH, 1000mbar
Tested by	Mick Chou		
Test Mode	Mode 1		

	Phase Of Power : Line (L)													
No	Frequency	Correction Reading Value Factor (dBuV)		e Emission Level Limit (dBuV) (dBuV)			Mar (d	-						
	(MHz)	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.				
1	0.38069	9.70	32.93	26.32	42.63	36.02	79.00	66.00	-36.37	-29.98				
2	0.42761	9.70	32.51	25.74	42.21	35.44	79.00	66.00	-36.79	-30.56				
3	0.66813	9.73	33.55	28.28	43.28	38.01	73.00	60.00	-29.72	-21.99				
4	7.62752	9.90	28.85	24.02	38.75	33.92	73.00	60.00	-34.25	-26.08				
5	12.73007	9.97	30.11	23.31	40.08	33.28	73.00	60.00	-32.92	-26.72				
6	15.34977	10.00	31.79	23.50	41.79	33.50	73.00	60.00	-31.21	-26.50				

- 1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value

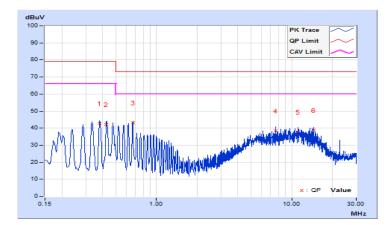




Frequency Range	150kHz ~ 30MHz	Detector Function & Bandwidth	Quasi-Peak (QP) / Average (AV), 9kHz
Input Power (System)	110Vac, 60Hz	Environmental Conditions	25℃, 69%RH, 1000mbar
Tested by	Mick Chou		
Test Mode	Mode 1		

	Phase Of Power : Neutral (N)											
No	Frequency	Correction Factor		g Value uV)	Emissio (dB	on Level uV)	Lir (dB	nit uV)	Mar (d	-		
	(MHz)	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.		
1	0.38069	9.71	32.89	26.34	42.60	36.05	79.00	66.00	-36.40	-29.95		
2	0.42761	9.71	32.47	25.72	42.18	35.43	79.00	66.00	-36.82	-30.57		
3	0.66813	9.74	33.52	28.23	43.26	37.97	73.00	60.00	-29.74	-22.03		
4	7.62752	9.92	28.59	23.88	38.51	33.80	73.00	60.00	-34.49	-26.20		
5	11.10742	9.98	27.64	22.59	37.62	32.57	73.00	60.00	-35.38	-27.43		
6	14.48957	10.02	28.70	26.48	38.72	36.50	73.00	60.00	-34.28	-23.50		

- 1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value

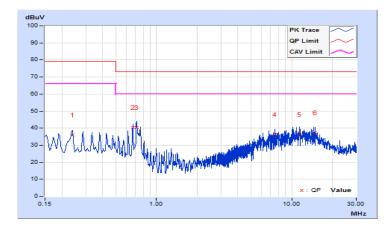




Frequency Range	150kHz ~ 30MHz	Detector Function &	Quasi-Peak (QP) /
Trequency Kange		Bandwidth	Average (AV), 9kHz
Input Power (System)	230Vac, 50Hz	Environmental	25℃, 69%RH, 1000mbar
Input Fower (System)	230 Vac, 301 12	Conditions	23 C, 09 %RH, 1000mbai
Tested by	Mick Chou		
Test Mode	Mode 1		

	Phase Of Power : Line (L)									
No	Frequency	Correction Factor		Reading Value Emission I (dBuV) (dBuV				nit uV)	Margin (dB)	
	(MHz)	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.23961	9.68	26.45	18.80	36.13	28.48	79.00	66.00	-42.87	-37.52
2	0.66813	9.73	30.61	17.46	40.34	27.19	73.00	60.00	-32.66	-32.81
3	0.71893	9.73	30.69	19.77	40.42	29.50	73.00	60.00	-32.58	-30.50
4	7.47503	9.90	26.39	22.32	36.29	32.22	73.00	60.00	-36.71	-27.78
5	11.47496	9.96	26.27	22.98	36.23	32.94	73.00	60.00	-36.77	-27.06
6	14.83365	9.99	27.41	25.39	37.40	35.38	73.00	60.00	-35.60	-24.62

- 1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value

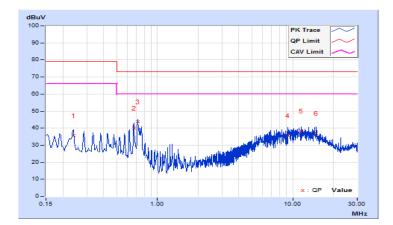




Frequency Range	150kHz ~ 30MHz	Detector Function &	Quasi-Peak (QP) /
Trequency Kange		Bandwidth	Average (AV), 9kHz
Input Power (System)	230Vac, 50Hz	Environmental Conditions	25℃, 69%RH, 1000mbar
Tested by	Mick Chou		
Test Mode	Mode 1		

	Phase Of Power : Neutral (N)									
No	Frequency	Correction Factor		g Value uV)	Emissio (dB		Lir (dB	nit uV)	Mar (d	-
	(MHz)	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.23993	9.69	26.13	18.42	35.82	28.11	79.00	66.00	-43.18	-37.89
2	0.66813	9.74	30.22	17.26	39.96	27.00	73.00	60.00	-33.04	-33.00
3	0.71505	9.75	34.02	24.03	43.77	33.78	73.00	60.00	-29.23	-26.22
4	9.24235	9.95	25.85	16.79	35.80	26.74	73.00	60.00	-37.20	-33.26
5	11.62354	9.99	28.24	23.42	38.23	33.41	73.00	60.00	-34.77	-26.59
6	15.00960	10.03	27.11	23.57	37.14	33.60	73.00	60.00	-35.86	-26.40

- 1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value





6 Asymmetric Mode Conducted Emission at Telecommunication Ports

6.1 Limits

For Class A Equipment

Frequency range (MHz)	Coupling device	Detector type / bandwidth	Voltage limits (dBuV)	Current limits (dBuA)
0.15 - 0.5	AAN	Quasi-peak / 9kHz	97 – 87	
0.5 - 30.0	AAN	Quasi-peak / 9ki iz	87	N/A
0.15 - 0.5	AAN		84-74	IN/A
0.5 - 30.0	AAN	Average / 9kHz	74	
0.15 - 0.5	CVP	Quesi peak / 0kHz	97 – 87	53 – 43
0.5 - 30.0	and current probe	Quasi-peak / 9kHz	87	43
0.15 - 0.5	CVP		84-74	40 - 30
0.5 - 30.0	and current probe	Average / 9kHz	74	30
0.15 - 0.5	Current Drohe			53 – 43
0.5 - 30.0	Current Probe	Quasi-peak / 9kHz	N/A	43
0.15 - 0.5	Current Probe	Average / 9kHz	IN/A	40 - 30
0.5 - 30.0		Average / 9KHZ		30

For Class B Equipment

Frequency range (MHz)	Coupling device	Detector type / bandwidth	Voltage limits (dBuV)	Current limits (dBuA)
0.15 - 0.5	AAN	Quasi-peak / 9kHz	84 – 74	
0.5 - 30.0	AAN		74	N/A
0.15 - 0.5	AAN		74-64	IN/A
0.5 - 30.0	AAN	Average / 9kHz	64	
0.15 - 0.5	CVP	Quasi pask / 0kHz	84 – 74	40 – 30
0.5 - 30.0	and current probe	Quasi-peak / 9kHz	74	30
0.15 - 0.5	CVP	Average / 9kHz	74-64	30 – 20
0.5 - 30.0	and current probe	Average / 9KHZ	64	20
0.15 - 0.5	Current Drobe			40 – 30
0.5 - 30.0	Current Probe	Quasi-peak / 9kHz	N/A	30
0.15 - 0.5	Current Probe	Average / 9kHz	IN/A	30 – 20
0.5 - 30.0		Average / 9KHZ		20



6.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
ROHDE & SCHWARZ TEST RECEIVER	ESR3	102414	Jan. 17, 2019	Jan. 16, 2020
ROHDE & SCHWARZ Artificial Mains Network (for EUT)	ENV216	101197	May 23, 2018	May 22, 2019
LISN With Adapter (for EUT)	AD10	C10Ada-002	May 23, 2018	May 22, 2019
ROHDE & SCHWARZ Artificial Mains Network (for peripherals)	ESH3-Z5	100218	Nov. 30, 2018	Nov. 29, 2019
SCHWARZBECK Artificial Mains Network (For EUT)	NNLK8129	8129229	May 3, 2018	May 2, 2019
SCHWARZBECK Artificial Mains Network (For EUT)	NNLK 8121	8121-808	Mar. 15, 2019	Mar. 14, 2020
Software	Cond_V7.3.7.4	NA	NA	NA
Software	ISN_V7.3.7.4	NA	NA	NA
RF cable (JYEBAO) With 10dB PAD	5D-FB	Cable-C10.01	Feb. 13, 2019	Feb. 12, 2020
SUHNER Terminator (For ROHDE & SCHWARZ LISN)	65BNC-5001	E1-010773	Feb. 18, 2019	Feb. 17, 2020
FCC ISN	F-071115-1057-1	20652	Jan. 17, 2019	Jan. 16, 2020

Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. The test was performed in Shielded Room No. 10.

3. The VCCI Site Registration No. T-11611.

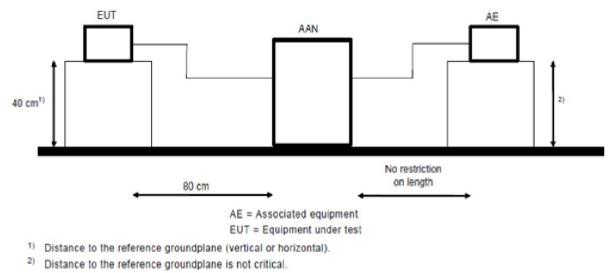
4. Tested Date: Apr. 11, 2019



6.3 Test Arrangement

Method of Using AANs:

- a. The EUT is placed 0.4 meters from the conducting wall of the shielded room and connected to AAN directly to reference ground plane.
- b. If voltage measurement is used, measure voltage at the measurement port of the AAN, correct the reading by adding the AAN voltage division factor, and compare to the voltage limit.
- c. It is not necessary to apply the voltage and the current limit if a AAN is used.
- d. The test results of disturbance at telecommunication ports are recorded of six worst margins for quasi-peak (mandatory) [and average (if necessary)] values against the limits at frequencies of interest unless the margin is 20 dB or greater.
- Note: The resolution bandwidth and video bandwidth of test receiver is 9kHz for quasi-peak detection (QP) and average detection (AV) at frequency 0.15MHz-30MHz.



Note: Cable on the RGP must to be insulated.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

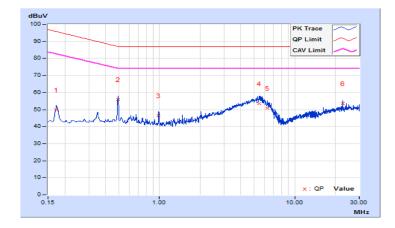


6.4 Test Results

Frequency Range	150kHz ~ 30MHz	Detector Function & Bandwidth	Quasi-Peak (QP) / Average (AV), 9kHz			
Input Power (System) 230Vac, 50Hz		Environmental Conditions	27℃, 66%RH, 1000mbar			
Tested by	Mick Chou					
Test Mode	Mode 1 LAN PORT 1 (1Gbps), PING+TFGEN					

No	Frequency	Correction Factor		g Value uV)	Emissic (dB			nit uV)	Mar (d	-
	(MHz)	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.17346	9.68	40.27	39.30	49.95	48.98	95.79	82.79	-45.84	-33.81
2	0.49408	9.40	46.53	45.66	55.93	55.06	87.10	74.10	-31.17	-19.04
3	0.98875	9.31	37.09	33.79	46.40	43.10	87.00	74.00	-40.60	-30.90
4	5.43401	9.20	44.47	33.28	53.67	42.48	87.00	74.00	-33.33	-31.52
5	6.31376	9.22	41.79	32.22	51.01	41.44	87.00	74.00	-35.99	-32.56
6	22.56763	10.00	43.51	41.28	53.51	51.28	87.00	74.00	-33.49	-22.72

- 1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value

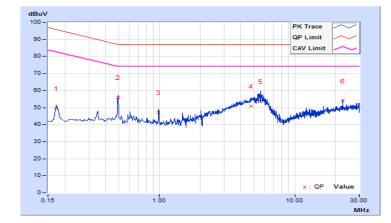




Eroqueney Benge	150kHz ~ 30MHz	Detector Function &	
Frequency Range		Bandwidth	Average (AV), 9kHz
Input Power (System)	230Vac, 50Hz	Environmental Conditions	27℃, 66%RH, 1000mbar
Tested by	Mick Chou		
Test Mode	Mode 1 LAN PORT 2 (1Gbps), PIN	IG+TFGEN	

No	Frequency	Correction Factor		g Value uV)	Emissic (dB			nit uV)	Maı (d	-
	(MHz)	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.17328	9.68	39.73	38.67	49.41	48.35	95.80	82.80	-46.39	-34.45
2	0.49408	9.40	46.53	45.44	55.93	54.84	87.10	74.10	-31.17	-19.26
3	0.98875	9.31	37.84	35.20	47.15	44.51	87.00	74.00	-39.85	-29.49
4	4.73844	9.19	41.50	27.71	50.69	36.90	87.00	74.00	-36.31	-37.10
5	5.57868	9.21	44.16	32.47	53.37	41.68	87.00	74.00	-33.63	-32.32
6	22.57154	10.00	44.03	41.95	54.03	51.95	87.00	74.00	-32.97	-22.05

- 1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value





7 Radiated Emission at Frequencies up to 1GHz

7.1 Limits

For Class A Equipment

· · ·		
Frequency range (MHz)	Distance (m)	Limits (dBuV/m)
30 - 230	10	40
230 - 1000	10	47
30 - 230	2	50
230 - 1000	5	57

For Class B Equipment

Frequency range (MHz)	Distance (m)	Limits (dBuV/m)	
30 - 230	10	30	
230 - 1000	10	37	
30 - 230	2	40	
230 - 1000	3	47	

7.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
ROHDE & SCHWARZ TEST RECEIVER	ESCI	100744	May 7, 2018	May 6, 2019
Schaffner BILOG Antenna	CBL6111D	22270	Nov. 21, 2018	Nov. 20, 2019
Sonoma Preamplifier	310N	352921	Feb. 19, 2019	Feb. 18, 2020
CT Turn Table	TT100	CT-080	NA	NA
CT Tower	AT100	CT-080	NA	NA
Software	Radiated_V7.6.15.9.5	NA	NA	NA
ANRITSU RF Switches	MP59B	NA	Mar. 6, 2019	Mar. 5, 2020
WOKEN RF cable With 5dB PAD	8D	CABLE-ST3-01	Mar. 6, 2019	Mar. 5, 2020

Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. The test was performed in Open Site No. 3.

3. The VCCI Site Registration No. is R-269.

4. Tested Date: Apr. 10, 2019

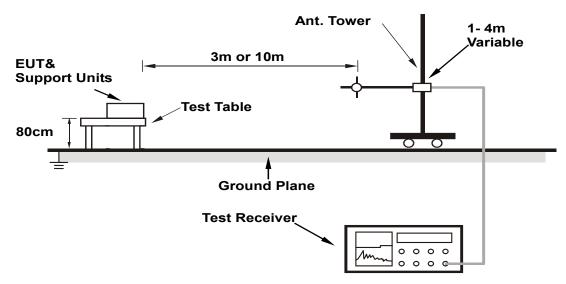


7.3 Test Arrangement

- a. The EUT was placed on the top of a rotating table 0.8 meters above the ground at an accredited test facility. The table was rotated 360 degrees to determine the position of the highest radiation.
- b. The EUT was set 10 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- c. The antenna is a broadband antenna, and its height is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- d. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- e. The test-receiver system was set to quasi-peak detect function and specified bandwidth with maximum hold mode when the test frequency is up to 1 GHz.

Note:

- 1. The resolution bandwidth and video bandwidth of test receiver/spectrum analyzer is 120kHz for quasi-peak detection (QP) at frequency up to 1GHz.
- 2. The measurement distance is the shortest horizontal distance between an imaginary circular periphery just encompassing this arrangement and the calibration point of the antenna.



Note: Cable on the RGP must to be insulated.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



7.4 Test Results

Frequency Range	30MHz ~ 1GHz	Detector Function & Bandwidth	Quasi-Peak (QP), 120kHz
Tested by	Vhenson Huang	Environmental Conditions	27℃, 60%RH, 1001mbar
Test Mode	Mode 1	·	

	Antenna Polarity & Test Distance : Horizontal at 10 m								
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)	
1	69.42	26.33 QP	40.00	-13.67	4.00 H	341	46.27	-19.94	
2	124.59	35.08 QP	40.00	-4.92	4.00 H	313	49.29	-14.21	
3	152.95	36.93 QP	40.00	-3.07	4.00 H	246	51.37	-14.44	
4	177.32	37.37 QP	40.00	-2.63	4.00 H	170	52.78	-15.41	
5	183.54	37.04 QP	40.00	-2.96	4.00 H	199	52.52	-15.48	
6	218.16	35.64 QP	40.00	-4.36	4.00 H	76	50.44	-14.80	
7	226.29	37.96 QP	40.00	-2.04	4.00 H	267	52.34	-14.38	
8	232.52	43.12 QP	47.00	-3.88	3.92 H	141	57.10	-13.98	
9	258.80	43.48 QP	47.00	-3.52	3.08 H	175	54.91	-11.43	
10	267.35	43.42 QP	47.00	-3.58	3.94 H	119	55.49	-12.07	
11	275.45	44.30 QP	47.00	-2.70	2.98 H	312	56.39	-12.09	
12	291.55	44.07 QP	47.00	-2.93	3.10 H	338	55.57	-11.50	
13	295.71	44.52 QP	47.00	-2.48	2.98 H	117	55.92	-11.40	
14	332.15	39.39 QP	47.00	-7.61	3.08 H	233	50.07	-10.68	
15	666.60	37.17 QP	47.00	-9.83	1.52 H	196	40.27	-3.10	
16	890.96	40.39 QP	47.00	-6.61	1.00 H	222	39.61	0.78	

Remarks:

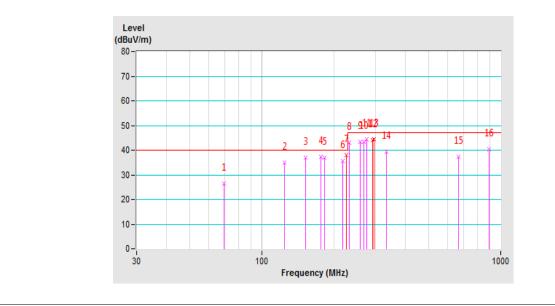
1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)

2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB)

- Pre-Amplifier Factor (dB)

3. The other emission levels were very low against the limit.

4. Margin value = Emission level – Limit value





Frequency Range	30MHz ~ 1GHz	Detector Function & Bandwidth	Quasi-Peak (QP), 120kHz
Tested by	Vhenson Huang	Environmental Conditions	27℃, 60%RH, 1001mbar
Test Mode	Mode 1		

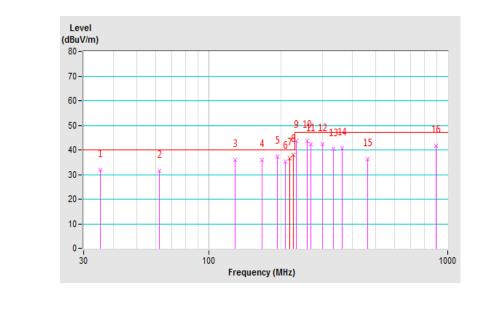
	Antenna Polarity & Test Distance : Vertical at 10 m									
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)		
1	35.22	31.83 QP	40.00	-8.17	1.15 V	156	43.40	-11.57		
2	62.05	31.63 QP	40.00	-8.37	1.66 V	47	52.26	-20.63		
3	128.64	35.92 QP	40.00	-4.08	1.00 V	300	50.01	-14.09		
4	167.06	35.94 QP	40.00	-4.06	1.00 V	12	51.01	-15.07		
5	193.72	37.43 QP	40.00	-2.57	1.00 V	246	52.81	-15.38		
6	209.87	35.18 QP	40.00	-4.82	1.00 V	296	50.29	-15.11		
7	217.97	36.47 QP	40.00	-3.53	1.00 V	18	51.29	-14.82		
8	226.11	37.92 QP	40.00	-2.08	1.00 V	26	52.31	-14.39		
9	232.46	43.74 QP	47.00	-3.26	1.00 V	51	57.72	-13.98		
10	258.80	43.77 QP	47.00	-3.23	1.00 V	90	55.20	-11.43		
11	266.90	42.44 QP	47.00	-4.56	1.00 V	350	54.48	-12.04		
12	299.32	42.50 QP	47.00	-4.50	1.00 V	202	53.85	-11.35		
13	332.15	40.22 QP	47.00	-6.78	1.00 V	139	50.90	-10.68		
14	362.75	40.55 QP	47.00	-6.45	1.00 V	75	50.23	-9.68		
15	461.23	36.25 QP	47.00	-10.75	2.14 V	212	43.02	-6.77		
16	890.94	41.68 QP	47.00	-5.32	2.28 V	314	40.90	0.78		

1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)

2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB)

– Pre-Amplifier Factor (dB)

- 3. The other emission levels were very low against the limit.
- 4. Margin value = Emission level Limit value





8 Radiated Emission at Frequencies above 1GHz

8.1 Limits

For Class A Equipment

Frequency range (MHz)	Distance (m)	Detector type	Limits (dBuV/m)
1000 - 3000		Average	56
3000 - 6000	3	Average	60
1000 - 3000		Peak	76
3000 - 6000		Feak	80

For Class B Equipment

Frequency range (MHz)	Distance (m)	Detector type	Limits (dBuV/m)
1000 - 3000		Average	50
3000 - 6000	3	Average	54
1000 - 3000		Peak	70
3000 - 6000		reak	74

Required highest frequency for radiated measurement

Highest internal frequency (F _x)	Highest measured frequency
$F_x \leq 108 \text{ MHz}$	1 GHz
108 MHz $<$ F_x \leq 500 MHz	2 GHz
500 MHz $<$ F _x \leq 1 GHz	5 GHz
$F_x > 1 \text{ GHz}$	5 x F_x up to a maximum of 6 GHz

NOTE 1 For FM and TV broadcast receivers, F_x is determined from the highest frequency generated or used excluding the local oscillator and tuned frequencies.

NOTE 2 F_x is highest fundamental frequency generated or used within the EUT or highest frequency at which it operates.

Where F_x is unknown, the radiated emission measurements shall be performed up to 6 GHz.



8.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
Agilent Spectrum	E4446A	MY51100009	Jun. 4, 2018	Jun. 3, 2019
Agilent Test Receiver	N9038A	MY50010135	Jun. 23, 2018	Jun. 22, 2019
Agilent Preamplifier	8449B	3008A01924	Feb. 21, 2019	Feb. 20, 2020
MITEQ Preamplifier	AMF-6F-260400-33-8P	892164	Feb. 21, 2019	Feb. 20, 2020
EMCI Preamplifier	EMC184045B	980235	Feb. 21, 2019	Feb. 20, 2020
ETS Preamplifier	3117-PA	00215857	Nov. 25, 2018	Nov. 24, 2019
Schwarzbeck Horn Antenna	BBHA-9170	212	Nov. 25, 2018	Nov. 24, 2019
EMCO Horn Antenna	3115	9312-4192 Nov. 25, 2018		Nov. 24, 2019
Max Full. Turn Table & Tower	MF7802	MF780208103	NA	NA
Software	Radiated_V8.7.08	NA	NA	NA
SUHNER RF cable With 4dB PAD	SF106-18	Cable-CH7-01	Aug. 13, 2018	Aug. 12, 2019
SUHNER RF cable With 3/4dB PAD	SF102	Cable-CH7-3.6m	Aug. 13, 2018	Aug. 12, 2019
MICRO-TRONICS Notch filter	BRC50703-01	010	May 31, 2018	May 30, 2019
MICRO-TRONICS Band Pass Filter	BRM17690	005	May 31, 2018	May 30, 2019

Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. The 3dB beamwidth of the horn antenna is minimum 40 degree (or w = 2.18m at 3m distance) for 1~6 GHz.

3. The test was performed in Chamber No. 7.

4. The VCCI Site Registration No. G-10039

5. Tested Date: Apr. 11, 2019

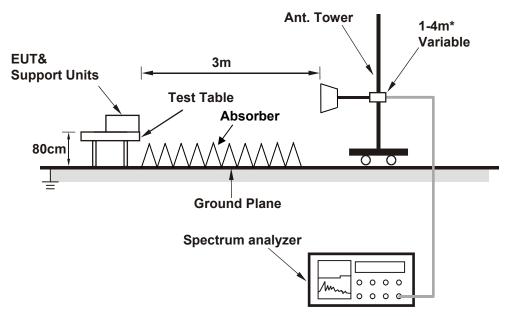


8.3 Test Arrangement

- a. The EUT was placed on the top of a rotating table 0.8 meters above the ground at an accredited chamber room. The table was rotated 360 degrees to determine the position of the highest radiation.
- b. The EUT was set 3 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- c. The height of antenna can be varied from one meter to four meters, the height of adjustment depends on the EUT height and the antenna 3dB beamwidth both, to detect the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- d. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- e. The spectrum analyzer system was set to peak and average detect function and specified bandwidth with maximum hold mode when the test frequency is above 1 GHz.

Note:

- 1. The resolution bandwidth of test receiver/spectrum analyzer is 1MHz and video bandwidth is 3MHz for Peak detection (PK) at frequency above 1GHz. The resolution bandwidth of test receiver/spectrum analyzer is 1 MHz for Average detection (AV) at frequency above 1GHz.
- 2. The measurement distance is the shortest horizontal distance between an imaginary circular periphery just encompassing this arrangement and the calibration point of the antenna.



Note: Cable on the RGP must to be insulated.

* :depends on the EUT height and the antenna 3dB beamwidth both.

For the actual test configuration, please refer to the related item - Photographs of the Test Configuration.



8.4 Test Results

Frequency Range	1GHz ~ 6GHz		Peak (PK) / Average (AV), 1MHz
Tested by	Ken Lee	Environmental Conditions	23℃, 71%RH, 1000mbar
Test Mode	Mode 1	·	

	Antenna Polarity & Test Distance : Horizontal at 3 m									
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)		
1	1186.74	54.16 PK	76.00	-21.84	1.00 H	235	59.69	-5.53		
2	1186.74	42.69 AV	56.00	-13.31	1.00 H	235	48.22	-5.53		
3	1499.70	52.90 PK	76.00	-23.10	1.05 H	343	58.74	-5.84		
4	1499.70	40.31 AV	56.00	-15.69	1.05 H	343	46.15	-5.84		
5	1780.05	52.38 PK	76.00	-23.62	1.02 H	232	57.17	-4.79		
6	1780.05	39.06 AV	56.00	-16.94	1.02 H	232	43.85	-4.79		
7	2000.05	56.20 PK	76.00	-19.80	2.00 H	349	59.87	-3.67		
8	2000.05	39.69 AV	56.00	-16.31	2.00 H	349	43.36	-3.67		
9	2957.84	54.30 PK	76.00	-21.70	2.89 H	210	54.95	-0.65		
10	2957.84	34.38 AV	56.00	-21.62	2.89 H	210	35.03	-0.65		
11	3492.74	55.51 PK	80.00	-24.49	1.53 H	146	54.30	1.21		
12	3492.74	38.91 AV	60.00	-21.09	1.53 H	146	37.70	1.21		
13	4499.99	50.54 PK	80.00	-29.46	2.14 H	72	47.58	2.96		
14	4499.99	35.30 AV	60.00	-24.70	2.14 H	72	32.34	2.96		

Remarks:

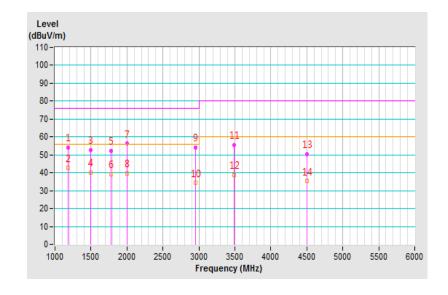
1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)

2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB)

– Pre-Amplifier Factor (dB)

3. The other emission levels were very low against the limit.

4. Margin value = Emission level – Limit value





Frequency Range	1GHz ~ 6GHz	Detector Function &	Peak (PK) /	
		Bandwidth	Average (AV), 1MHz	
Tested by	Ken Lee	Environmental	23℃, 71%RH, 1000mbar	
		Conditions		
Test Mode	Mode 1			

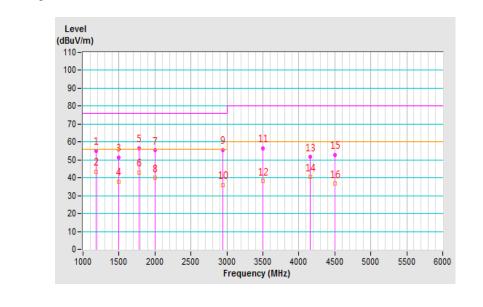
Antenna Polarity & Test Distance : Vertical at 3 m								
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)
1	1186.79	55.22 PK	76.00	-20.78	1.73 V	201	60.75	-5.53
2	1186.79	43.58 AV	56.00	-12.42	1.73 V	201	49.11	-5.53
3	1496.90	51.47 PK	76.00	-24.53	1.07 V	220	57.32	-5.85
4	1496.90	37.68 AV	56.00	-18.32	1.07 V	220	43.53	-5.85
5	1780.08	56.41 PK	76.00	-19.59	2.00 V	209	61.20	-4.79
6	1780.08	43.04 AV	56.00	-12.96	2.00 V	209	47.83	-4.79
7	1999.89	55.35 PK	76.00	-20.65	1.02 V	201	59.02	-3.67
8	1999.89	39.92 AV	56.00	-16.08	1.02 V	201	43.59	-3.67
9	2945.14	55.55 PK	76.00	-20.45	2.19 V	155	56.29	-0.74
10	2945.14	35.89 AV	56.00	-20.11	2.19 V	155	36.63	-0.74
11	3500.18	56.34 PK	80.00	-23.66	1.59 V	224	55.10	1.24
12	3500.18	38.09 AV	60.00	-21.91	1.59 V	224	36.85	1.24
13	4153.55	51.56 PK	80.00	-28.44	2.00 V	242	48.93	2.63
14	4153.55	40.44 AV	60.00	-19.56	2.00 V	242	37.81	2.63
15	4499.99	52.80 PK	80.00	-27.20	2.15 V	356	49.84	2.96
16	4499.99	36.65 AV	60.00	-23.35	2.15 V	356	33.69	2.96

1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)

2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB)

– Pre-Amplifier Factor (dB)

- 3. The other emission levels were very low against the limit.
- 4. Margin value = Emission level Limit value





9 Harmonics Current Measurement

9.1 Limits

Limits for Class A equipment		Limits for Class D equipment				
Harmonic Order	Max. permissible harmonics current	Harmonic Order	Max. permissible harmonics current per	Max. permissible harmonics current		
n	A	n	watt mA/W	A		
C	Odd harmonics	Odd Harmonics only				
3	2.30	3	3.4	2.30		
5	1.14	5	1.9	1.14		
7	0.77	7	1.0	0.77		
9	0.40	9	0.5	0.40		
11	0.33	11	0.35	0.33		
13	0.21	13	0.30	0.21		
15≦n≦39	0.15 x 15/n	15≦n≦39	3.85/n	0.15 x 15/n		
Even harmonics						
2	1.08					
4	0.43					
6	0.30					
8≦n≦40	0.23 x 8/n					

Notes: 1. Class A and Class D are classified according to section 5 of EN 61000-3-2.

 According to section 7 of EN 61000-3-2, the above limits for all equipment except for lighting equipment having an active input power > 75 W and no limits apply for equipment with an active input power up to and including 75 W.

9.2 Classification of Equipment

Class A	Class B	Class C	Class D
Balanced three-phase equipment;	Portable tools;	Lighting	Equipment having a specified
Household appliances excluding	Arc welding	equipment.	power less than or equal to 600
equipment as Class D;	equipment which is		W of the following types:
Tools excluding portable tools;	not professional		Personal computers and
Dimmers for incandescent lamps;	equipment.		personal computer monitors;
Audio equipment;			Television receivers;
Equipment not specified in one of the			Refrigerators and freezers
three other classes.			having one or more
			variable-speed drives to control
			compressor motor(s).

9.3 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
Teseq Harmonics - Flicker Test System	Profline 2105	32A00983 & 1639A01863	Sep. 27, 2018	Sep. 26, 2019
Software	CTS 4	NA	NA	NA

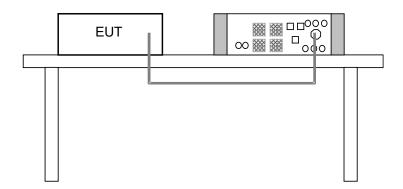
Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

- 2. The test was performed in EMS Room No. 1.
- 3. According to IEC 61000-4-7: 2002, the time window shall be synchronized with each group of 10 or 12 cycles (200 ms)for power frequency of 50 or 60Hz.
- 4. Tested Date: Apr. 15, 2019



9.4 Test Arrangement

- a. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the maximum harmonic components under normal operating conditions for each successive harmonic component in turn.
- b. The correspondent test program of test instrument to measure the current harmonics emanated from EUT is chosen. The measure time shall be not less than the time necessary for the EUT to be exercised.



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



9.5 Test Results

	230.31Vrms/ 0.249Arms	Power Frequency	49.99Hz
Power Consumption	27.9W	Power Factor	0.494
Environmental Conditions	22 °C, 69%RH	Tested by	Chiming Li
Test Mode	Mode 1		

Note: 1. Limits are not specified for equipment with a rated power of 75W or less (other than lighting equipment).

2. According to EN 61000-3-2 the manufacturer shall specify the power of the apparatus. This value shall be used for establishing limits. The specified power shall be within +/-10% of the measured power.



10 Voltage Fluctuations and Flicker Measurement

10.1 Limits

Test item	Limit	Note
P _{st}	1.0	P _{st:} short-term flicker severity.
P _{lt}	0.65	P _{lt:} long-term flicker severity.
T _{max} (ms)	500	$T_{max:}$ maximum time duration during the observation period that the voltage deviation d(t) exceeds the limit for d _c .
d _{max} (%)	4	d _{max:} maximum absolute voltage change during an observation period.
d _c (%)	3.3	d _c maximum steady state voltage change during an observation period.

10.2 Test Instruments

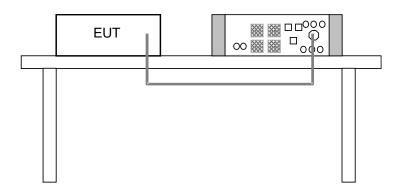
Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
Teseq Harmonics - Flicker Test System	Profline 2105	32A00983 & 1639A01863	Sep. 27, 2018	Sep. 26, 2019
Software	CTS 4	NA	NA	NA

Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

- 2. The test was performed in EMS Room No. 1.
- 3. Tested Date: Apr. 15, 2019

10.3 Test Arrangement

- a. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the most unfavorable sequence of voltage changes under normal operating conditions.
- b. During the flick measurement, the measure time shall include that part of whole operation cycle in which the EUT produce the most unfavorable sequence of voltage changes. The observation period for short-term flicker indicator is 10 minutes and the observation period for long-term flicker indicator is 2 hours.



For the actual test configuration, please refer to the related item - Photographs of the Test Configuration.



10.4 Test Results

Observation (T _p)	10 min.	Power Frequency	49.99 Hz
Fundamental Voltage/Ampere	230.31 Vrms / 0.249 Arms	Power Factor	0.494
Environmental Conditions	22°C, 69 % RH	Tested by	Chiming Li
Test Mode	Mode 1		

Test Parameter	Measurement Value	Limit	Remarks
P _{st}	0.064	1.00	Pass
P _{lt}	0.028	0.65	Pass
T _{max} (ms)	0	500	Pass
d _{max} (%)	0	4	Pass
d _c (%)	0	3.3	Pass

Note: (1) P_{st} means short-term flicker indicator.
(2) P_{lt} means long-term flicker indicator.
(3) T_{max} means accumulated time value of d(t) with a deviation exceeding 3.3 %.
(4) d_{max} means maximum relative voltage change.
(5) d_c means maximum relative steady-state voltage change.



11 General Immunity Requirements

Clause	Reference standard	Table	Test specification	Performance Criterion
4.2.1	EN/IEC 61000-4-2 ESD	1.3	Enclosure port: ±8kV Air discharge, ±4kV Contact discharge	В
4.2.3.2	EN/IEC 61000-4-3 RS	1.2	Enclosure port: 80-1000 MHz, 3V/m, 80% AM (1kHz)	А
4.2.2	2.3 EN/IEC 61000-4-4		Signal ports and telecommunication ports: xDSL equipment: ±0.5kV, 5/50 (T _r /T _h) ns, 100kHz others: ±0.5kV, 5/50 (T _r /T _h) ns, 5kHz	В
	EFT	3.3	Input DC power port: ± 0.5 kV, 5/50 (T _r /T _h) ns, 5kHz	
		4.5	Input AC Power ports: ±1kV, 5/50 (T _r /T _h) ns, 5kHz	
		2.2	Signal and telecommunication ports (direct to outdoor cables): 10/700 (5/320) (T _r /T _h) µs w/o primary protectors: ±1kV, or with primary protectors fitted: ±4kV	С
4.2.5	EN/IEC 61000-4-5 Surge	3.2	Input DC power port (direct to outdoor cables): 1.2/50 (8/20) (T _r /T _h) μs Line to earth: ±0.5kV	
	4.4	Input AC Power ports: 1.2/50 (8/20) (T _r /T _h) μs, Line to line: ±1kV Line to earth: ±2kV	В	
		2.1	Signal and telecommunication ports(cable length > 3m): 0.15-80 MHz, 3V, 80% AM (1kHz)	
4.2.3.3	EN/IEC 61000-4-6 CS	3.1	Input DC power port: 0.15-80 MHz, 3V, 80% AM (1kHz)	А
		4.1	Input AC Power ports: 0.15-80 MHz, 3V, 80% AM (1kHz)	
4.2.4	EN/IEC 61000-4-8 PFMF	1.1	Enclosure port: 50 or 60 Hz, 1A/m	А
4.2.6	EN/IEC 61000-4-11	4.2	Input AC Power ports: Voltage Dips: >95% reduction – 0.5 period 30% reduction – 25 periods	B C
	Dips & Interruptions	4.3	Input AC Power ports: Voltage Interruptions:	
			>95% reduction – 250 periods	С

11.1 Performance Criteria

General Performance Criteria

Performance criterion A

The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

Performance criterion B

After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test. If the minimum performance level (or the permissible performance loss) is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

Performance criterion C

Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions. Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

Particular performance criteria

The particular performance criteria which are specified in the normative annexes of EN 55024 take precedence over the corresponding parts of the general performance criteria. Where particular performance criteria for specific functions are not given, then the general performance criteria shall apply.

12 Electrostatic Discharge Immunity Test (ESD)

12.1 Test Specification

Basic Standard:	EN/IEC 61000-4-2
Discharge Impedance:	330 ohm / 150 pF
Discharge Voltage:	Air Discharge: ±2, ±4, ±8kV (Direct) Contact Discharge: ±2, ±4kV (Direct/Indirect)
Number of Discharge:	Air – Direct: 10 discharges per location (each polarity) Contact – Direct & Indirect: 25 discharges per location (each polarity) and min. 200 times in total
Discharge Mode:	Single Discharge
Discharge Period:	1-second minimum

12.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
KeyTek, ESD Simulator	MZ-15/EC	0504259	Nov. 12, 2018	Nov. 11, 2019

Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

- 2. The test was performed in ESD Room No. 1.
- 3. Tested Date: Apr. 16, 2019

12.3 Test Arrangement

The discharges shall be applied in two ways:

a. Contact discharges to the conductive surfaces and coupling planes:

The EUT shall be exposed to at least 200 discharges, 100 each at negative and positive polarity, at a minimum of four test points. One of the test points shall be subjected to at least 50 indirect discharges to the center of the front edge of the horizontal coupling plane. The remaining three test points shall each receive at least 50 direct contact discharges. If no direct contact test points are available, then at least 200 indirect discharges shall be applied in the indirect mode. Test shall be performed at a maximum repetition rate of one discharge per second.

b. Air discharges at slots and apertures and insulating surfaces:

On those parts of the EUT where it is not possible to perform contact discharge testing, the equipment should be investigated to identify user accessible points where breakdown may occur. Such points are tested using the air discharge method. This investigation should be restricted to those area normally handled by the user. A minimum of 10 single air discharges shall be applied to the selected test point for each such area.



The basic test procedure was in accordance with EN/IEC 61000-4-2:

- a. Electrostatic discharges were applied only to those points and surfaces of the EUT that are accessible to users during normal operation.
- b. The test was performed with at least ten single discharges on the pre-selected points in the most sensitive polarity.
- c. The time interval between two successive single discharges was at least 1 second.
- d. The ESD generator was held perpendicularly to the surface to which the discharge was applied and the return cable was at least 0.2 meters from the EUT.
- e. Contact discharges were applied to the non-insulating coating, with the pointed tip of the generator penetrating the coating and contacting the conducting substrate.
- f. Air discharges were applied with the round discharge tip of the discharge electrode approaching the EUT as fast as possible (without causing mechanical damage) to touch the EUT. After each discharge, the ESD generator was removed from the EUT and re-triggered for a new single discharge. The test was repeated until all discharges were complete.
- g. At least ten single discharges (in the most sensitive polarity) were applied to the Horizontal Coupling Plane at points on each side of the EUT. The ESD generator was positioned at a distance of 0.1 meters from the EUT with the discharge electrode touching the HCP.
- h. At least ten single discharges (in the most sensitive polarity) were applied to the center of one vertical edge of the Vertical Coupling Plane in sufficiently different positions that the four faces of the EUT were completely illuminated. The VCP (dimensions 0.5m x 0.5m) was placed vertically to and 0.1 meters from the EUT.

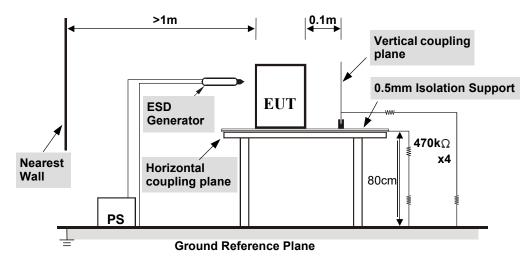


TABLE-TOP EQUIPMENT

The configuration consisted of a wooden table 0.8 meters high standing on the **G**round **R**eference **P**lane. The **GRP** consisted of a sheet of aluminum at least 0.25mm thick, and 2.5 meters square connected to the protective grounding system. A Horizontal Coupling Plane (1.6m x 0.8m) was placed on the table and attached to the **GRP** by means of a cable with 940k Ω total impedance. The equipment under test, was installed in a representative system as described in section 7 of

EN/IEC 61000-4-2, and its cables were placed on the **HCP** and isolated by an insulating support of 0.5mm thickness. A distance of 1-meter minimum was provided between the EUT and the walls of the laboratory and any other metallic structure.

For the actual test configuration, please refer to the related item - Photographs of the Test Configuration.



12.4 Test Results

Input Power (System)	230 Vac, 50 Hz	Tested by	Chiming Li
Environmental Conditions	23 °C, 43% RH 1011 mbar	Test mode	Mode 1

Test Results of Direct Application					
Discharge Level (kV)	Polarity (+/-)	Test Point	Contact Discharge	Air Discharge	Performance Criterion
2	+/-	1, 2, 3	Note 1	NA	А
4	+/-	1, 2, 3	Note 2	NA	В
2	+/-	4 ~ 12	NA	Note 1	А
4, 8	+/-	12	NA	Note 1	A
4, 8	+/-	4 ~ 11	NA	Note 2	В

Description of test points of direct application: Please refer to following page for representative mark only.

Test Results of Indirect Application					
Discharge	Polarity	Test Point	Horizontal	Vertical Coupling	Performance
Level (kV)	(+/-)	Iest Follit	Coupling Plane	Plane	Criterion
2, 4	+/-	Four Sides	Note	Note	А

Description of test points of indirect application:

1. Front side

2. Rear side

3. Right side

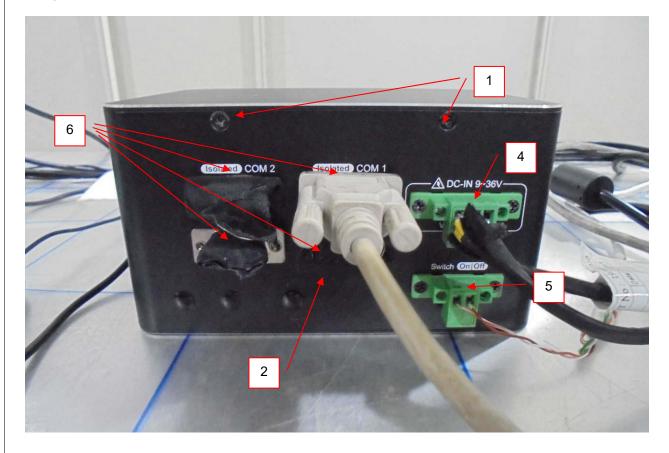
4. Left side

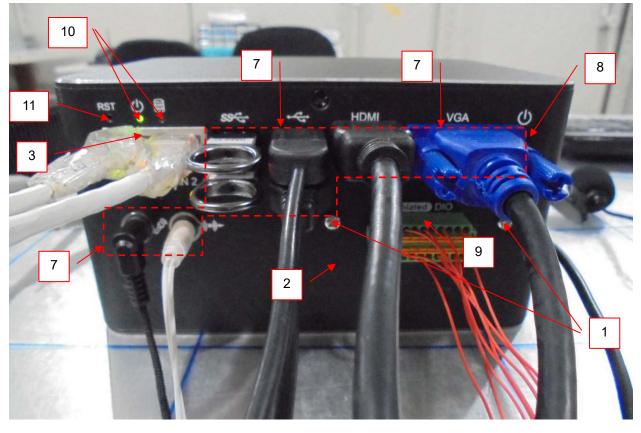
Note: 1. The EUT function was correct during the test.

2. There was flicker disturbance on screen during the test, but self-recoverable after the test.

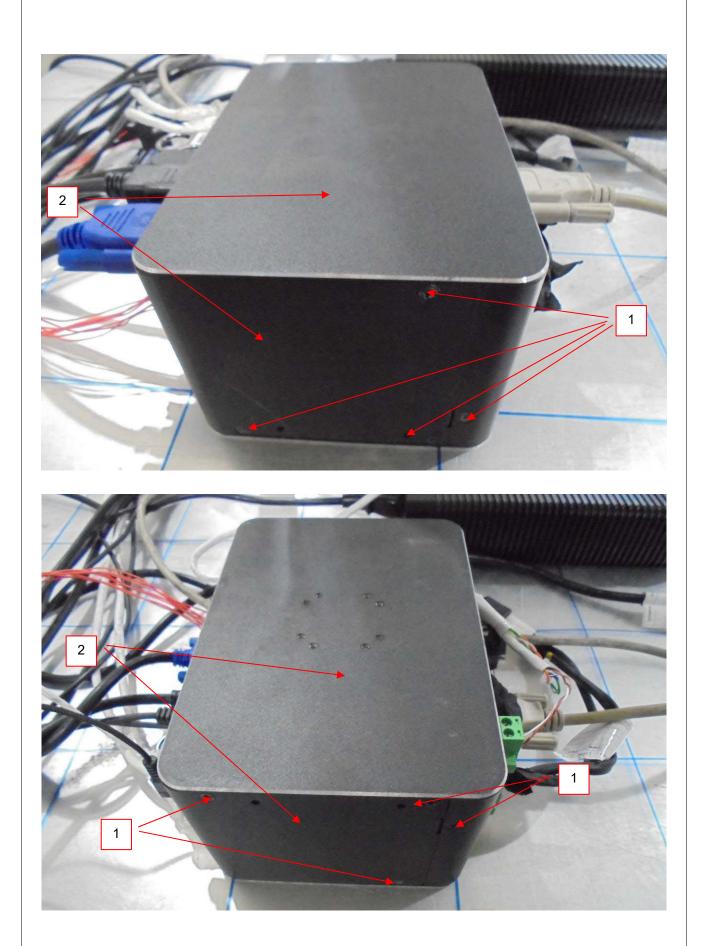


Description of Test Points

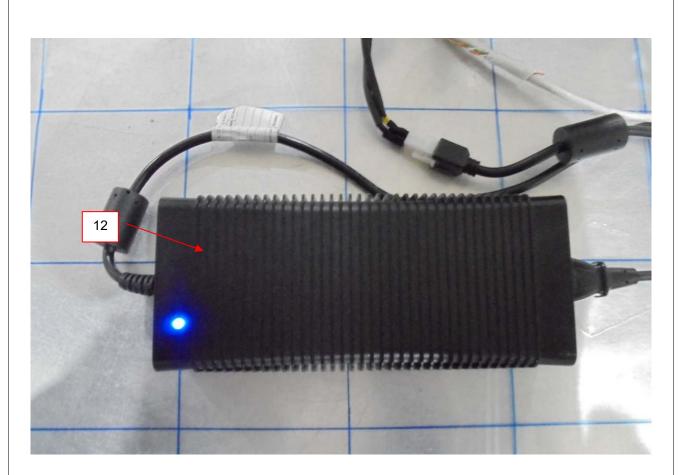














13.1 Test Specification

Basic Standard:	EN/IEC 61000-4-3
Frequency Range:	80 MHz - 1000 MHz
Field Strength:	3 V/m
Modulation:	1kHz Sine Wave, 80%, AM Modulation
Frequency Step:	1 % of preceding frequency value
Polarity of Antenna:	Horizontal and Vertical
Antenna Height:	1.5m
Dwell Time:	3 seconds

13.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
Signal Generator KEYSIGHT	N5182B	MY53051971	Oct. 02, 2018	Oct. 01, 2019
Power Amplifier ETS-LINGREN	8100-002	00163537	NA	NA
Power Amplifier ETS-LINGREN	8100-008	00163547	NA	NA
RF Voltage Meter KEYSIGHT	N1914A	MY55326005	Sep. 27, 2018	Sep. 26, 2019
LOG ANTENNA ETS-LINGREN	3150B	00203052	NA	NA
LOG ANTENNA AR	AT5080ANT	309740	NA	NA
HORN ANTENNA ETS-LINGREN	3119	00203652	NA	NA
TILE!(Software) ETS-LINGREN	7.1.3.34	NA	NA	NA

Note:

1. The calibration interval of the above test instruments are 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. The test was performed in Chamber RS-1Room. (TAF No.: 2022)

3 The transmit antenna was located at a distance of 3.0 meters from the EUT.

4. Tested Date: Apr. 26, 2019



13.3 Test Arrangement

The test procedure was in accordance with EN/IEC 61000-4-3.

- a. The testing was performed in a fully anechoic chamber.
- b. The frequency range is swept from 80 MHz to 1000 MHz, with the signal 80% amplitude modulated with a 1kHz sine wave.
- c. The field strength level was 3 V/m.
- d. The test was performed with the EUT exposed to both vertically and horizontally polarized fields on each of the four sides.

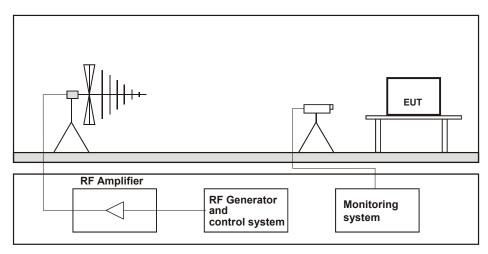


Table-top Equipment

The EUT installed in a representative system as described in section 7 of EN/IEC 61000-4-3 was placed on a non-conductive table 0.8 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



13.4 Test Results

Input Power (System)	230 Vac, 50 Hz	Tested by	Vito Lung
Environmental Conditions	23 °C, 70% RH	Test mode	Mode 1

	Delority	Azimuth(°)	Applied	d Field Strength	Observation	Performance
Frequency (MHz)	Polarity	Azimuth(°)	(V/m)	Modulation	Observation	Criterion
80 -1000	V&H	0	3	80% AM (1kHz)	Note	А
80 -1000	V&H	90	3	80% AM (1kHz)	Note	А
80 -1000	V&H	180	3	80% AM (1kHz)	Note	А
80 -1000	V&H	270	3	80% AM (1kHz)	Note	А

Note: The EUT function was correct during the test.

* The test, calibration and test results are compliance with the TAF No.: 2022.

14 Electrical Fast Transient/Burst Immunity Test (EFT)

14.1 Test Specification

Basic Standard:	EN/IEC 61000-4-4
Test Voltage:	Signal / telecommunication port: ±0.5kV Input DC power port: N/A Input AC power port: ±1kV
Impulse Repetition Frequency:	xDSL telecommunication port: 100kHz others: 5kHz
Impulse Wave Shape:	5/50 ns
Burst Duration:	0.75 ms for 100kHz Repetition Frequency 15 ms for 5kHz Repetition Frequency
Burst Period:	300 ms
Test Duration:	1 min.

14.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
Haefely, EFT Generator	PEFT 4010	154954	Apr. 25, 2018	Apr. 24, 2019
Haefely,Capacitive Clamp	IP4A	155173	Apr. 25, 2018	Apr. 24, 2019

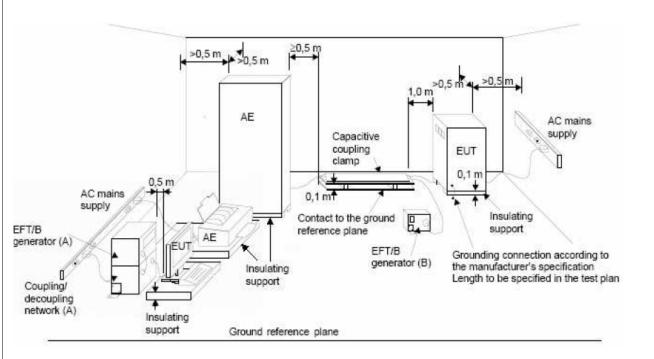
Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

- 2. The test was performed in EFT Room.
- 3. Tested Date: Apr. 18, 2019

14.3 Test Arrangement

- a. Both positive and negative polarity discharges were applied.
- b. The distance between any coupling devices and the EUT should be 0.5 m for table-top equipment testing, and 1.0 m for floor standing equipment.
- c. The duration time of each test sequential was 1 minute.
- d. The transient/burst waveform was in accordance with EN/IEC 61000-4-4, 5/50 ns.





NOTE:

- (A) location for supply line coupling
- (B) location for signal lines coupling

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

14.4 Test Results

Input Power (System)	230 Vac, 50 Hz	Tested by	Thomas Cheng
Environmental Conditions	23°C, 69% RH	Test mode	Mode 1

Input AC power port

Voltage (kV)	Test Point	Polarity (+/-)	Observation	Performance Criterion
1	L1	+/-	Note	A
1	L2	+/-	Note	A
1	PE	+/-	Note	A
1	L1-L2-PE	+/-	Note	A

Telecommunication port

Voltage (kV)	Test Point	Polarity (+/-)	Observation	Performance Criterion
0.5	RJ 45	+/-	Note	А

Note: The EUT function was correct during the test.



15 Surge Immunity Test

15.1 Test Specification

Basic Standard:	EN/IEC 61000-4-5
Wave-Shape:	Signal / telecommunication port (direct to outdoor cables*): 10/700 μs Open Circuit Voltage 5/320 μs Short Circuit Current
	Input DC power port (direct to outdoor cables*): 1.2/50 μs Open Circuit Voltage 8/20 μs Short Circuit Current
	Input AC power port: 1.2/50 μs Open Circuit Voltage 8/20 μs Short Circuit Current
Test Voltage:	Signal and telecommunication ports**: w/o primary protectors: N/A, with primary protectors fitted: N/A
	Input DC power port: Line to earth or ground:N/A
	Input AC power ports: Line to line: ±0.5kV, ±1kV, Line to earth or ground: ±0.5kV, ±1kV, ±2kV
AC Phase Angle (degree):	0°, 90°, 180°, 270°
Pulse Repetition Rate:	1 time / 20 sec.
Number of Tests:	5 positive and 5 negative at selected points
* This test is only applicable on	nly to ports, which according to the manufacturer's specification, ma

* This test is only applicable only to ports, which according to the manufacturer's specification, may connect directly to outdoor cables.

** For ports where primary protection is intended, surges are applied at voltages up to 4 kV with the primary protectors fitted. Otherwise the 1 kV test level is applied without primary protection in place.

15.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
KeyTek, Surge Simulator	EMC Pro	9902207	May 11, 2018	May 10, 2019
Coupling Decoupling Network	CDN-UTP8	045	Aug. 27, 2018	Aug. 26, 2019
Software	CEWare32	NA	NA	NA

Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. The test was performed in EMS Room No. 1.

3. Tested Date: Apr. 16, 2019



15.3 Test Arrangement

a. Input AC/DC Power ports:

The surge is to be applied to the EUT power supply terminals via the capacitive coupling network. Decoupling networks are required in order to avoid possible adverse effects on equipment not under test that may be powered by the same lines, and to provide sufficient decoupling impedance to the surge wave. The power cord between the EUT and the coupling/decoupling networks shall be 2 meters in length (or shorter).

For double-insulated products without PE or external earth connections, the test shall be done in a similar way as for grounded products but without adding any additional external grounded connections. If there are no other possible connections to earth, line-to-ground tests may be omitted.

b. Signal and telecommunication ports,

• Unshielded unsymmetrical interconnection lines:

The surge is applied to the lines via the capacitive coupling. The coupling / decoupling networks shall not influence the specified functional conditions of the EUT. The interconnection line between the EUT and the coupling/decoupling networks shall be 2 meters in length.

• Unshielded symmetrical interconnections communication lines:

The surge is applied to the lines via gas arrestors coupling. Test levels below the ignition point of the coupling arrestor cannot be specified. The interconnection line between the EUT and the coupling/decoupling networks shall be 2 meters in length.

High speed communications lines

Prior to the test, the correct operation of the port shall be verified; the external connection shall then be removed and the surge applied directly to the port's terminals with no coupling /decoupling network. After the surge, the correct operation of the port shall again be verified.

- Shielded lines:
 - Direct application,

The EUT is isolated from ground and the surge is applied to its metallic enclosure; the termination (or auxiliary equipment) at the port(s) under test is grounded. This test applies to equipment with single or multiple shielded cables.

Rules for application of the surge to shielded lines:

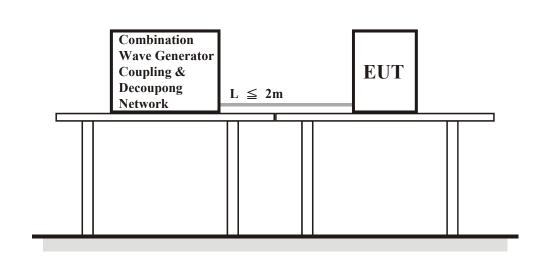
- a) Shields grounded at both ends
 - The surge injection on the shield.
- b) Shields grounded at one end
 - If in the installation the shield is connected only at the auxiliary equipment, test shall be done in that configuration but with the generator still connected to the EUT side. If cable lengths allow, the cables shall be on insulated supports 0,1 m above the ground plane or cable tray.

For products which do not have metallic enclosures, the surge is applied directly to the shielded cable.

- Alternative coupling method for testing single cables in a multi-shield configuration,

Surges are applied in close proximity to the interconnection cable under test by a wire. The length of the cable between the port(s) under test and the device attached to the other end of the cable shall be the lesser of: the maximum length permitted by the EUT's specification, or 20 m. Where the length exceeds 1 m, excess lengths of cables shall be bundled at the approximate centre of the cables with the bundles 30 cm to 40 cm in length.





For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

15.4 Test Results

Input Power (System)	230 Vac, 50 Hz	Tested by	Chiming Li
Environmental Conditions	23 °C, 69% RH	Test mode	Mode 1

Input AC power port

Voltage (kV)	Test Point	Polarity (+/-)	Observation	Performance Criterion
0.5, 1	L1-L2	+/-	Note 1	A
0.5, 1, 2	L1-PE	+/-	Note 2	В
0.5, 1, 2	L2-PE	+/-	Note 2	В

Note: 1. The EUT function was correct during the test.

2. There was flicker disturbance on screen during the test, but self-recoverable after the test.



16 Immunity to Conducted Disturbances Induced by RF Fields (CS)

16.1 Test Specification

Basic Standard:	EN/IEC 61000-4-6
Frequency Range:	0.15 MHz - 80 MHz
Voltage Level:	3 V
Modulation:	1kHz Sine Wave, 80%, AM Modulation
Frequency Step:	1 % of preceding frequency value
Dwell Time	3 seconds



16.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
ROHDE & SCHWARZ Signal Generator	SML03	101801	Jan. 14, 2019	Jan. 13, 2020
Digital Sweep Function Generator	8120	984801	NA	NA
AR Power Amplifier	75A250AM1	306331	NA	NA
FCC Coupling Decoupling Network	FCC-801-M2-16A	01047	Jun. 20, 2018	Jun. 19, 2019
FISCHER CUSTOM COMMUNICATIONS EM Injection Clamp	F-203I-23mm	455	NA	NA
FISCHER CUSTOM COMMUNICATIONS Current Injection Clamp	F-120-9A	361	Jul. 24, 2018	Jul. 23, 2019
B&K Ear Simulator	4185	2553594	NA	NA
EM TEST Coupling Decoupling Network	CDN M1/32A	306508	Jun. 20, 2018	Jun. 19, 2019
TESEQ Coupling Decoupling Network	CDN T800	34428	Jun. 20, 2018	Jun. 19, 2019
TESEQ Coupling Decoupling Network	CDN T800	29459	Jun. 20, 2018	Jun. 19, 2019
FCC Coupling Decoupling Network	FCC-801-T4	02031	Jun. 20, 2018	Jun. 19, 2019
EM TEST Coupling Decoupling Network	CDN T2	306509	Jun. 20, 2018	Jun. 19, 2019
R&S Power Sensor	NRV-Z5	837878/039	Nov. 10, 2018	Nov. 9, 2019
R&S Power Meter	NRVD	837794/040	Nov. 10, 2018	Nov. 9, 2019
TESEQ Coupling Decoupling Network	CDN M232	37702	Jun. 20, 2018	Jun. 19, 2019
TESEQ Coupling Decoupling Network	CDN M332	41258	Jun. 20, 2018	Jun. 19, 2019
TESEQ Coupling Decoupling Network	CDN M332	41256	Jun. 20, 2018	Jun. 19, 2019
TESEQ Coupling Decoupling Network	CDN T400A	28569	Jun. 20, 2018	Jun. 19, 2019
TESEQ Coupling Decoupling Network	CDN T8-10	40376	Jun. 20, 2018	Jun. 19, 2019
TESEQ Coupling Decoupling Network	ISN ST08	41212	Jun. 20, 2018	Jun. 19, 2019
FCC Coupling Decoupling Network	FCC-801-M5-50A	100018	Jan. 21, 2019	Jan. 20, 2020
Software	CS_V7.4.2	NA	NA	NA

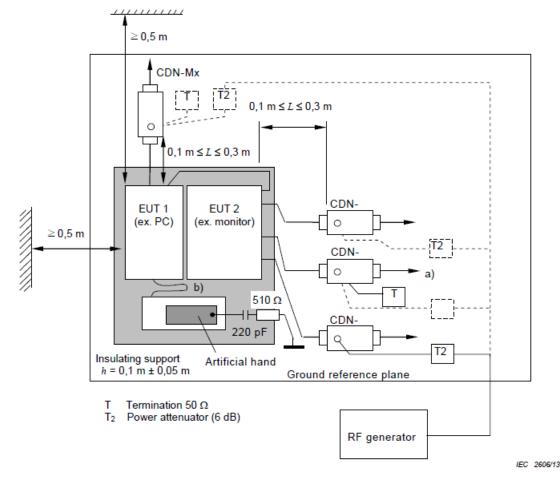
Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

- 2. The test was performed in CS Room No. 1.
- 3. Tested Date: Apr. 16, 2019



16.3 Test Arrangement

- a. The EUT shall be tested within its intended operating and climatic conditions.
- b. An artificial hand was placed on the hand-held accessory and connected to the ground reference plane.
- c. One of the CDNs not used for injection was terminated with 50 ohm, providing only one return path. All other CDNs were coupled as decoupling networks.
- d. The frequency range is swept from 150 kHz to 80 MHz, using the signal level established during the setting process and with a disturbance signal of 80 % amplitude. The signal is modulated with a 1 kHz sine wave, pausing to adjust the RF signal level or the switch coupling devices as necessary. Where the frequency is swept incrementally, the step size shall not exceed 1 % of the preceding frequency value.
- e. Attempts should be made to fully exercise the EUT during testing, and to fully interrogate all exercise modes selected for susceptibility.



- **Note:** 1. The EUT clearance from any metallic obstacles shall be at least 0,5 m.
 - 2. Interconnecting cables (\leq 1 m) belonging to the EUT shall remain on the insulating support.
 - 3. The equipment to be tested is placed on an insulating support of 0.1 meters height above a ground reference plane. All relevant cables shall be provided with the appropriate coupling and decoupling devices at a distance between 0.1 meters and 0.3 meters from the projected geometry of the EUT on the ground reference plane.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



16.4 Test Results

Input Power (System)	230 Vac, 50 Hz	Tested by	Chiming Li
Environmental Conditions	23 °C, 67% RH	Test mode	Mode 1

Frequency (MHz)	Level (Vrms)	Tested Line	Injection Method	Return Path	Observation	Performance Criterion
0.15 – 80	3	AC Power	CDN-M3	CDN-T8	Note	А
0.15 – 80	3	RJ45	CDN-T8	CDN-M3	Note	A

Note: The EUT function was correct during the test.

17 Power Frequency Magnetic Field Immunity Test

17.1 Test Specification

Basic Standard:	EN/IEC 61000-4-8
Frequency Range:	50Hz
Field Strength:	1 A/m
Observation Time:	1 minute
Inductance Coil:	Rectangular type, 1 m x 1 m

17.2 Test Instruments

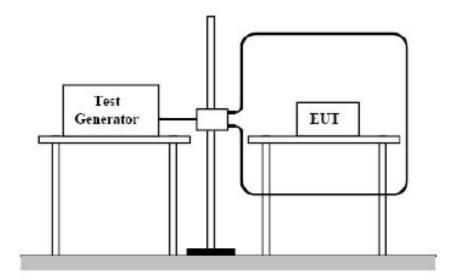
Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
HAEFELY Magnetic Field Tester	MAG 100	083794-06	NA	NA
COMBINOVA Magnetic Field Meter	MFM10	224	Apr. 24, 2018	Apr. 23, 2019

Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

- 2. The test was performed in EMS Room No. 1
- 3. Tested Date: Apr. 16, 2019

17.3 Test Arrangement

- a. The equipment is configured and connected to satisfy its functional requirements.
- b. The power supply, input and output circuits shall be connected to the sources of power supply, control and signal.
- c. The cables supplied or recommended by the equipment manufacturer shall be used. 1 meter of all cables used shall be exposed to the magnetic field.



TABLETOP EQUIPMENT

The equipment shall be subjected to the test magnetic field by using the induction coil of standard dimension (1 m x 1 m). The induction coil shall then be rotated by 90 degrees in order to expose the EUT to the test field with different orientations.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



17.4 Test Results

Input Power (System)	230 Vac, 50 Hz	Tested by	Chiming Li
Environmental Conditions	22 °C, 69% RH	Test mode	Mode 1

Application	Frequency (Hz)	Field Strength (A/m)	Observation	Performance Criterion
X - Axis	50	1	Note	A
Y - Axis	50	1	Note	A
Z - Axis	50	1	Note	A

Note: The EUT function was correct during the test.

18 Voltage Dips and Interruptions

18.1 Test Specification

Basic Standard:	EN/IEC 61000-4-11
Test levels:	Voltage Dips:
	>95% reduction – 0.5 period
	30% reduction – 25 periods
	Voltage Interruptions:
	>95% reduction – 250 periods
Interval between Event:	Minimum ten seconds
Sync Angle (degrees):	0° / 180°
Test Cycle:	3 times

18.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
Teseq Immunity Test System	Profline 2105	1632A00983 & 1639A01863	Sep. 27, 2018	Sep. 26, 2019
Software	WIN2120	NA	NA	NA

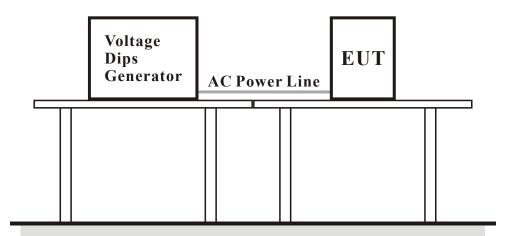
Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. The test was performed in EMS Room No. 1.

3. Tested Date: Apr. 16, 2019

18.3 Test Arrangement

The EUT shall be tested for each selected combination of test levels and duration with a sequence of 3 dips/interruptions with intervals of 10 s minimum (between each test event). Each representative mode of operation shall be tested. Abrupt changes in supply voltage shall occur at 0 degree crossover point of the voltage waveform.



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



18.4 Test Results

	230 Vac, 50 Hz 240 Vac, 50 Hz 100 Vac, 50 Hz	Tested by	Chiming Li
Environmental Conditions	22 °C, 68% RH	Test mode	Mode 1

Input Power for testing: 230 Vac, 50 Hz (Nominal input Voltage)						
Voltage Reduction (%)Duration (period)Interval (sec)TimesObservationPerformance Criterion						
>95	0.5	10	3	Note 1	А	
30	25	10	3	Note 1	А	
>95	250	10	3	Note 2	С	

Input Power for testing: 240 Vac, 50 Hz (Maximum rated input voltage)								
Voltage Reduction (%)	Duration (period)	Interval (sec)	Times	Observation	Performance Criterion			
>95	0.5	10	3	Note 1	А			
30	25	10	3	Note 1	А			
>95	250	10	3	Note 2	C			

Input Power for testing: 100 Vac, 50 Hz (Minimum rated input voltage)								
Voltage Reduction (%)	Duration (period)	Interval (sec)	Times	Observation	Performance Criterion			
>95	0.5	10	3	Note 1	А			
30	25	10	3	Note 1	А			
>95	250	10	3	Note 2	С			

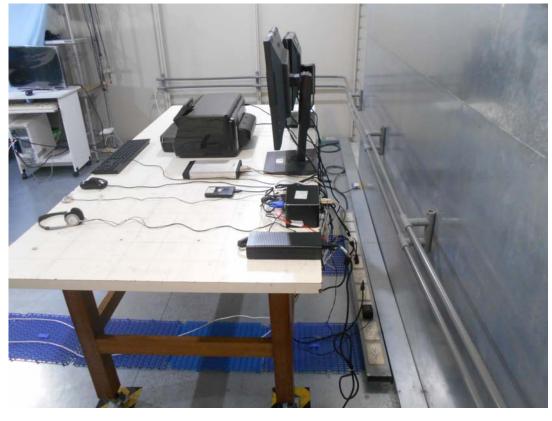
Note: 1. The EUT function was correct during the test.2. The EUT shut down but could be restored by the operator.



19 Pictures of Test Arrangements

19.1 Conducted Emission from the AC Mains Power Port

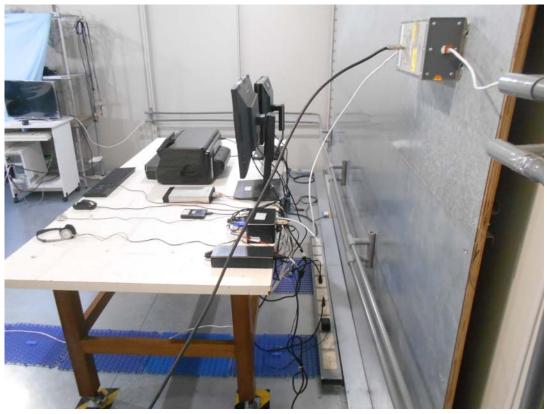






19.2 Asymmetric Mode Conducted Emission at Telecommunication Ports

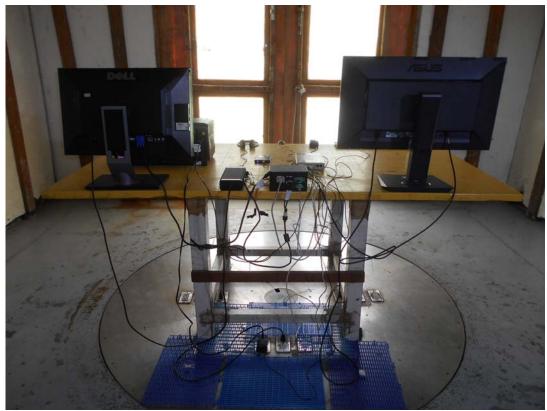






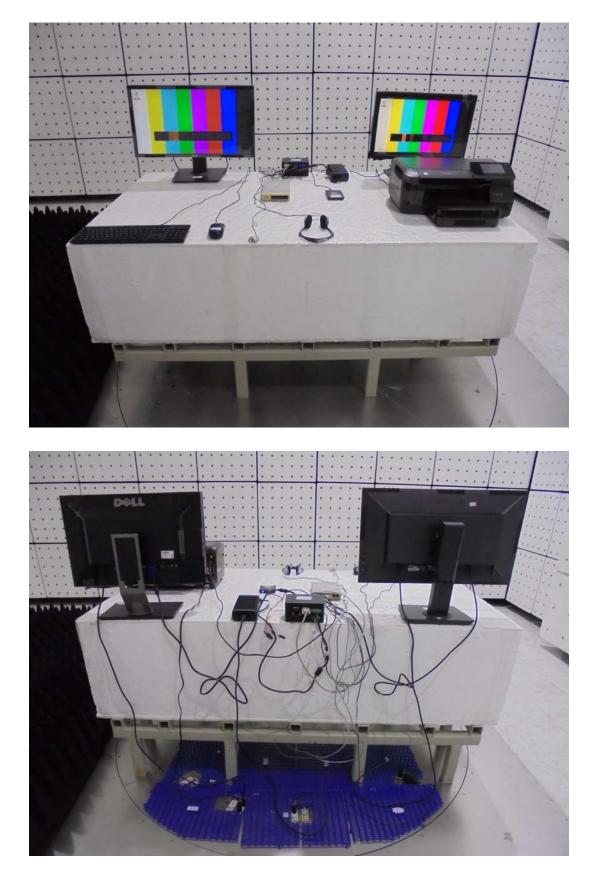


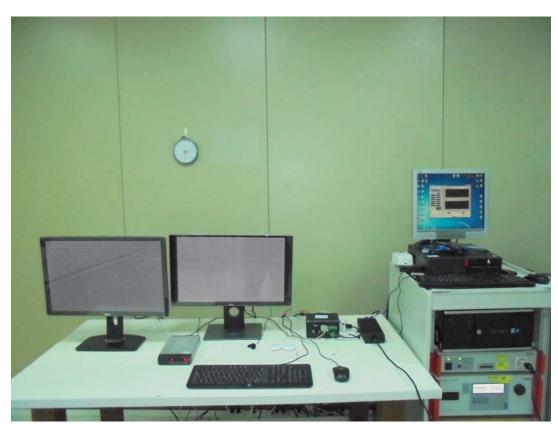
19.3 Radiated Emission at Frequencies up to 1GHz





19.4 Radiated Emission at Frequencies above 1GHz





19.5 Harmonics Current, Voltage Fluctuations and Flicker Measurement

19.6 Electrostatic Discharge Immunity Test (ESD)





19.7 Radio-frequency, Electromagnetic Field Immunity Test (RS)



19.8 Electrical Fast Transient/Burst Immunity Test (EFT)





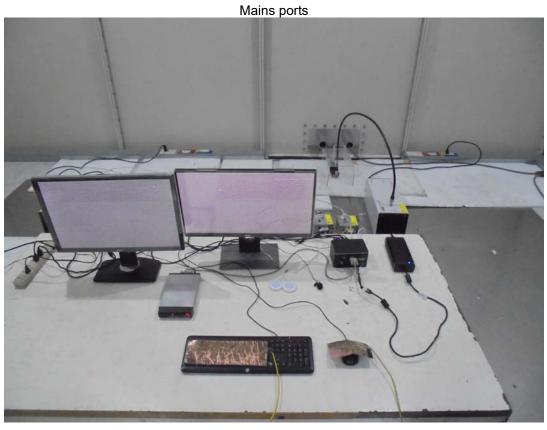


19.9 Surge Immunity Test





19.10 Conducted Disturbances Induced by RF Fields (CS)



LAN





19.11 Power Frequency Magnetic Field Immunity Test (PFMF)



19.12 Voltage Dips and Interruptions





Appendix – Information of the Testing Laboratories

We, Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch, were founded in 1988 to provide our best service in EMC, Radio, Telecom and Safety consultation. Our laboratories are accredited and approved according to ISO/IEC 17025.

If you have any comments, please feel free to contact us at the following:

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The address and road map of all our labs can be found in our web site also.

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